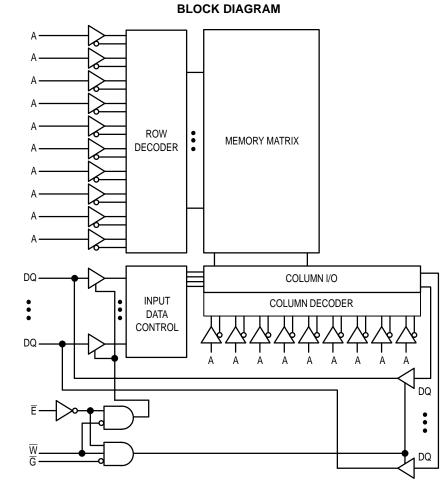
512K x 8 Bit Static Random Access Memory

The MCM6946/SCM6946 is a 4,194,304–bit static random access memory organized as 524,288 words of 8 bits. Static design eliminates the need for external clocks or timing strobes.

The MCM6946/SCM6946 is equipped with chip enable (\overline{E}) and output enable (\overline{G}) pins, allowing for greater system flexibility and eliminating bus contention problems. Either input, when high, will force the outputs into high impedance.

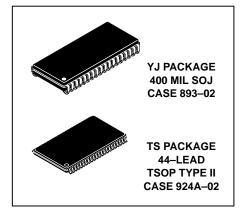
The MCM6946 is available in a 400 mil, 36-lead surface-mount SOJ package.

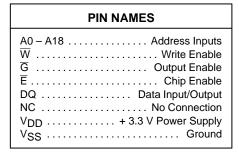
- Single 3.3 V 5%, + 10% Power Supply
- Fast Access Time: 8/10/12/15 ns
- Equal Address and Chip Enable Access Time
- All Inputs and Outputs are TTL Compatible
- Three-State Outputs
- Power Operation: 195/185/180/175 mA Maximum, Active AC
- Available in TSOP or SOJ Packages



REV 8 1/29/99









PIN ASSIGNMENTS

4	100 MIL SOJ		-	TSOP TYP	PEII
ΑŪ	1• 36	1 NC	IC [1•	44 🛛 NC
АΟ	2 35	1 A [IC [2	43 🛛 NC
АŪ	3 34	_	Α	3	42 🛛 NC
ΑŪ		_	Α	4	41 🛛 A
		_	Α[40 🛛 A
АЦ	5 32	JA	Α [-	39 🛛 A
ĒŪ	6 31] <u>G</u>	A		38 🛛 A
DQ [7 30] DQ	Ē (-	37 🛛 д
ρα [8 29	DQ)Q [9	36 🛛 DQ
_		L)Q [10	35 🛛 DQ
V _{DD})D [11	34 🛛 V _{SS}
v _{ss} [10 27] V _{DD} V _S	_{SS} [12	33 🛛 V _{DD}
DQ [11 26)Q [1.2	32 🛛 DQ
DQ [12 25	L DQ)Q [14	31 🛛 DQ
ΨC	13 24	_	W	15	30 🛛 A
_			Αĺ	16	29 🛛 A
АЦ	14 23] A	Αĺ	17	28 🛛 A
АЦ	15 22] A	A [27 🛛 A
АС	16 21] A	Α [19	26 🛛 A
АС	17 20] A	Α [25 🛛 NC
АŪ			IC [21	24 🛛 NC
^ ५	10 19	1 100	IC [22	23 🛛 NC

TRUTH TABLE (X = Don't Care)

Ē	G	W	Mode	I/O Pin	Cycle	Current
Н	Х	Х	Not Selected	High–Z		I _{SB1} , I _{SB2}
L	н	н	Output Disabled	High–Z		IDDA
L	L	н	Read	D _{out}	Read	I _{DDA}
L	Х	L	Write	High–Z	Write	IDDA

ABSOLUTE MAXIMUM RATINGS (See Note)

Rating	Symbol	Value	Unit
Power Supply Voltage Relative to $V_{\ensuremath{SS}}$	V _{DD}	- 0.5 to 5.0	V
Voltage Relative to V _{SS} for Any Pin Except V _{DD}	V _{in} , V _{out}	– 0.5 to V _{DD} + 0.5	V
Output Current (per I/O)	l _{out}	± 20	mA
Power Dissipation	PD	1.0	W
Temperature Under Bias	T _{bias}	– 10 to 85	°C
Operating Temperature	ТА	0 to 70	°C
Storage Temperature — Plastic	T _{stg}	– 55 to 150	°C

NOTE: Permanent device damage may occur if ABSOLUTE MAXIMUM RATINGS are exceeded. Functional operation should be restricted to RECOMMENDED OPER-ATING CONDITIONS. Exposure to higher than recommended voltages for extended periods of time could affect device reliability. This device contains circuitry to protect the inputs against damage due to high static voltages or electric fields; however, it is advised that normal precautions be taken to avoid application of any voltage higher than maximum rated voltages to these high-impedance circuits.

This BiCMOS memory circuit has been designed to meet the dc and ac specifications shown in the tables, after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow of at least 500 linear feet per minute is maintained.

DC OPERATING CONDITIONS AND CHARACTERISTICS

(V_{DD} = 3.3 V - 5%, + 10%, T_A = 0 to 70°C, Unless Otherwise Noted)

RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol	Min	Тур	Max	Unit
Supply Voltage (Operating Voltage Range)	V _{DD}	3.135	3.3	3.6	V
Input High Voltage	VIH	2.2	_	V _{DD} + 0.3**	V
Input Low Voltage	VIL	- 0.5*	_	0.8	V

* V_{IL} (min) = -0.5 V dc; V_{IL} (min) = -2.0 V ac (pulse width ≤ 2.0 ns). ** V_{IH} (max) = V_{DD} + 0.3 V dc; V_{IH} (max) = V_{DD} + 2.0 V ac (pulse width ≤ 2.0 ns).

DC CHARACTERISTICS

Parameter	Symbol	Min	Max	Unit
Input Leakage Current (All Inputs, V _{in} = 0 to V _{DD})	l _{lkg(l)}	—	± 1.0	μΑ
Output Leakage Current ($\overline{E} = V_{IH}$, $V_{out} = 0$ to V_{DD})	I _{lkg(O)}	—	± 1.0	μΑ
Output Low Voltage (I _{OL} = + 8.0 mA)	VOL	—	0.4	V
Output High Voltage (I _{OH} = - 4.0 mA)	VOH	2.4	_	V

POWER SUPPLY CURRENTS

Parameter		Symbol	0 to 70°C	Unit	
AC Active Supply Current (I _{out} = 0 mA, V _{DD} = Max)	SCM6946–8: t _{AVAV} = 8 ns MCM6946–10: t _{AVAV} = 10 ns MCM6946–12: t _{AVAV} = 12 ns MCM6946–15: t _{AVAV} = 15 ns	IDD	195 185 180 175	mA	
AC Standby Current ($V_{DD} = Max$, $\overline{E} = V_{IH}$, No Other Restrictions on Other Inputs)	SCM6946–8: t _{AVAV} = 8 ns MCM6946–10: t _{AVAV} = 10 ns MCM6946–12: t _{AVAV} = 12 ns MCM6946–15: t _{AVAV} = 15 ns	I _{SB1}	55 50 50 45	mA	
CMOS Standby Current ($\overline{E} \ge V_{DD} - 0.2 \text{ V}, V_{in} \le V_{SS} + 0 \text{ (V}_{DD} = \text{Max}, f = 0 \text{ MHz})$	$0.2 \text{ V or } \ge \text{V}_{DD} - 0.2 \text{ V}$	I _{SB2}	20	mA	

CAPACITANCE (f = 1.0 MHz, dV = 3.3 V, T_A = 25°C, Periodically Sampled Rather Than 100% Tested)

	Parameter	Symbol	Тур	Max	Unit
Input Capacitance	All Inputs Except Clocks and DQs $\overline{E}, \overline{G}, \overline{W}$	C _{in} C _{ck}	4 5	6 8	pF
Input/Output Capacitance	DQ	C _{I/O}	5	8	pF

AC OPERATING CONDITIONS AND CHARACTERISTICS

 $(V_{DD} = 3.3 V - 5\%, + 10\%, T_A = 0 \text{ to } 70^{\circ}\text{C}, \text{ Unless Otherwise Noted})$

Input Pulse Levels	0 to 3.0 V
Input Rise/Fall Time	2 ns
Input Timing Measurement Reference Level	1.5 V

READ CYCLE TIMING (See Notes 1 and 2)

		SCM6	SCM6946-8		946–10	MCM6946-12		MCM6946-15			
Parameter	Symbol	Min	Max	Min	Max	Min	Max	Min	Max	Unit	Notes
Read Cycle Time	t _{AVAV}	8	—	10	—	12	_	15	—	ns	3
Address Access Time	^t AVQV	—	8	—	10	—	12	-	15	ns	
Enable Access Time	^t ELQV	—	8	—	10	—	12	_	15	ns	4
Output Enable Access Time	^t GLQV	—	4	—	5	—	6	—	7	ns	
Output Hold from Address Change	^t AXQX	2	—	2	—	2	_	2	—	ns	
Enable Low to Output Active	^t ELQX	3	—	3	—	3	_	3	—	ns	5, 6, 7
Output Enable Low to Output Active	^t GLQX	0	—	0	—	0	—	0	—	ns	5, 6, 7
Enable High to Output High-Z	^t EHQZ	0	4	0	5	0	6	0	7	ns	5, 6, 7
Output Enable High to Output High–Z	^t GHQZ	0	4	0	5	0	6	0	7	ns	5, 6, 7

NOTES:

1. \overline{W} is high for read cycle.

2. Product sensitivities to noise require proper grounding and decoupling of power supplies as well as minimization or elimination of bus contention conditions during read and write cycles.

3. All read cycle timings are referenced from the last valid address to the first transitioning address.

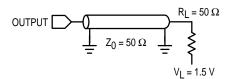
4. Addresses valid prior to or coincident with \overline{E} going low.

5. At any given voltage and temperature, tEHQZ max < tELQX min, and tGHQZ max < tGLQX min, both for a given device and from device to device.

6. Transition is measured \pm 200 mV from steady–state voltage.

7. This parameter is sampled and not 100% tested.

8. Device is continuously selected ($\overline{E} \leq V_{IL}, \overline{G} \leq V_{IL}$).

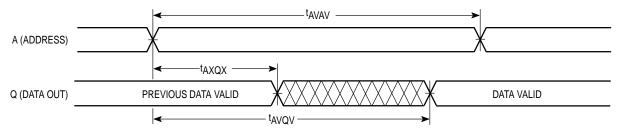


TIMING LIMITS

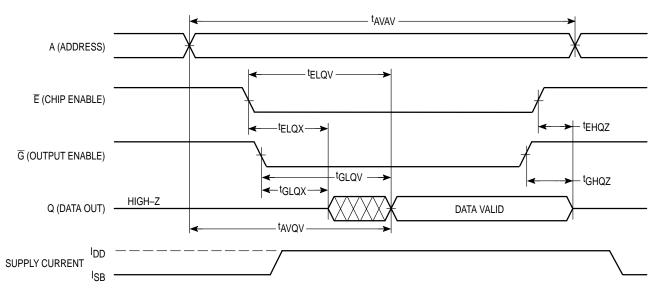
The table of timing values shows either a minimum or a maximum limit for each parameter. Input requirements are specified from the external system point of view. Thus, address setup time is shown as a minimum since the system must supply at least that much time. On the other hand, responses from the memory are specified from the device point of view. Thus, the access time is shown as a maximum since the device never provides data later than that time.

Figure 1. AC Test Load

READ CYCLE 1 (See Note 8)



READ CYCLE 2 (See Note 4)



WRITE CYCLE 1 (W Controlled; See Notes 1, 2, and 3)

		SCM6	946–8	MCM6	MCM6946-10		946–12	MCM6946-15		2 MCM6946–15			
Parameter	Symbol	Min	Max	Min	Max	Min	Max	Min	Max	Unit	Notes		
Write Cycle Time	t _{AVAV}	8	—	10	—	12	—	15	—	ns	4		
Address Setup Time	^t AVWL	0.5	—	0.5	—	0.5	—	0.5	—	ns			
Address Valid to End of Write	^t AVWH	8	_	9	—	10	—	12	—	ns			
Address Valid to End of Write (\overline{G} High)	^t AVWH	7	_	8	—	9	—	10	—	ns			
Write Pulse Width	^t WLWH ^t WLEH	8	_	9	_	10	_	12	_	ns			
Write Pulse Width (\overline{G} High)	^t WLWH ^t WLEH	7	—	8	—	9	_	10	_	ns			
Data Valid to End of Write	^t DVWH	6	_	6	—	6	_	7	—	ns			
Data Hold Time	^t WHDX	0	—	0	—	0	—	0	—	ns			
Write Low to Data High-Z	twlqz	0	4	0	5	0	6	0	7	ns	5, 6, 7		
Write High to Output Active	^t WHQX	3	—	3	—	3	—	3	—	ns	5, 6, 7		
Write Recovery Time	^t WHAX	0	—	0	—	0	—	0	—	ns			

NOTES:

1. A write occurs during the overlap of \overline{E} low and \overline{W} low.

2. Product sensitivities to noise require proper grounding and decoupling of power supplies as well as minimization or elimination of bus contention conditions during read and write cycles.

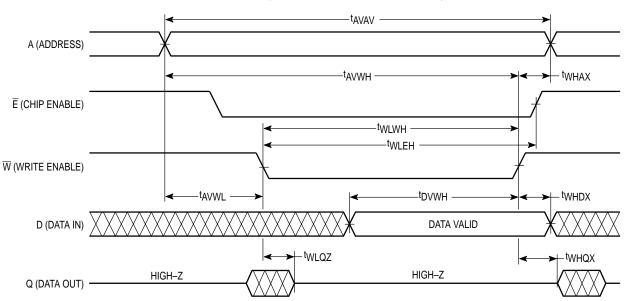
3. If \overline{G} goes low coincident with or after \overline{W} goes low, the output will remain in a high-impedance state.

4. All write cycle timings are referenced from the last valid address to the first transitioning address.

5. Transition is measured \pm 200 mV from steady-state voltage.

6. This parameter is sampled and not 100% tested.

7. At any given voltage and temperature, tWLOZ max < tWHOX min, both for a given device and from device to device.



WRITE CYCLE 1 (W Controlled; See Notes 1, 2, and 3)

WRITE CYCLE 2 (E Controlled; See Notes 1, 2, and 3)

		SCM6	SCM6946-8		946–10	MCM6946-12		MCM6946-15			
Parameter	Symbol	Min	Max	Min	Max	Min	Max	Min	Max	Unit	Notes
Write Cycle Time	t _{AVAV}	8	_	10	—	12	_	15	—	ns	4
Address Setup Time	^t AVEL	0	—	0	—	0	—	0	—	ns	
Address Valid to End of Write	^t AVEH	8	—	9	—	10	—	12	—	ns	
Address Valid to End of Write (\overline{G} High)	^t AVEH	7	—	8	—	9	_	10	—	ns	
Enable Pulse Width	^t ELEH, ^t ELWH	8	_	9	—	10	_	12	_	ns	5, 6
Enable Pulse Width (\overline{G} High)	^t ELEH, ^t ELWH	7	_	8	—	9	_	10	_	ns	5, 6
Data Valid to End of Write	^t DVEH	6	—	6	—	6	—	7	—	ns	
Data Hold Time	^t EHDX	0	—	0	—	0	—	0	—	ns	
Write Recovery Time	^t EHAX	0	—	0	—	0	—	0	—	ns	

NOTES:

1. A write occurs during the overlap of \overline{E} low and \overline{W} low.

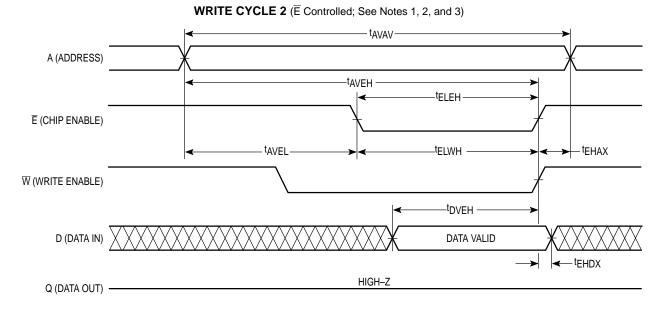
2. Product sensitivities to noise require proper grounding and decoupling of power supplies as well as minimization or elimination of bus contention conditions during read and write cycles.

3. If \overline{G} goes low coincident with or after \overline{W} goes low, the output will remain in a high-impedance state.

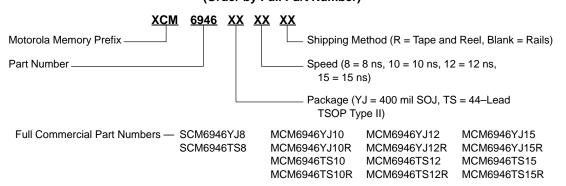
4. All write cycle timing is referenced from the last valid address to the first transitioning address.

5. If E goes low coincident with or after W goes low, the output will remain in a high-impedance condition.

6. If \overline{E} goes high coincident with or before \overline{W} goes high, the output will remain in a high-impedance condition.

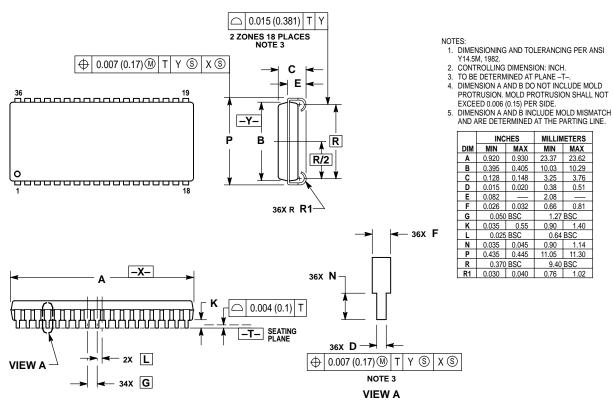


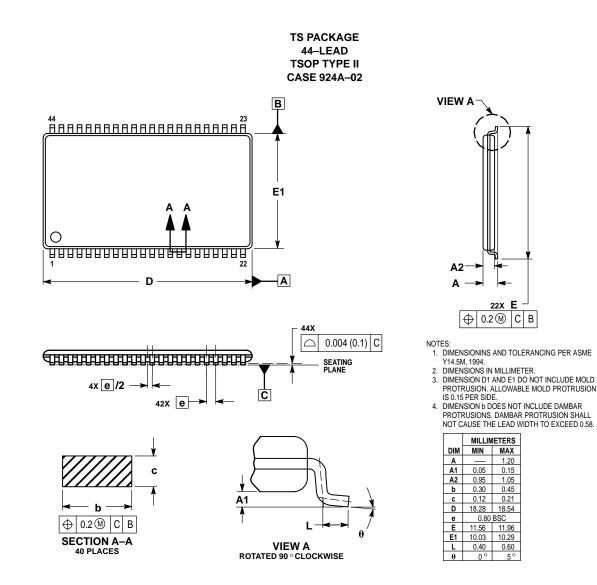
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